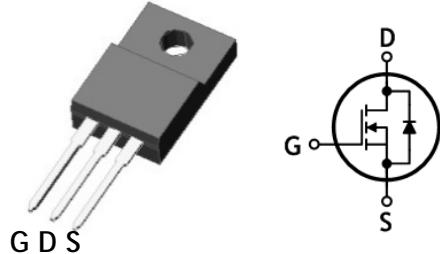


HIGH SPEED SWITCHING APPLICATION

Features

- Low drain-source On resistance: $R_{DS(on)}=0.6\Omega$ (Typ.)
- Low gate charge: $Q_g=35nC$ (Typ.)
- Low reverse transfer capacitance: $C_{rss}=18pF$ (Typ.)
- RoHS compliant device
- 100% avalanche tested

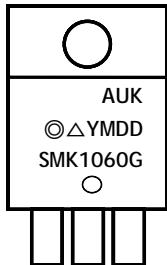


Ordering Information

Part Number	Marking	Package
SMK1060FG	SMK1060G	TO-220FT-3L (Short Dambar)

TO-220FT-3L

Marking Information



Column 1: Manufacturer
Column 2: Production Information
e.g.) ©△YMDD
- ©: Option Code
- △: Factory Management Code
- YMDD: Date Code (Year, Month, Daily)
Column 3: Device Code

Absolute maximum ratings ($T_c=25^\circ C$ unless otherwise noted)

Characteristic	Symbol		Rating	Unit
Drain-source voltage	V_{DSS}		600	V
Gate-source voltage	V_{GSS}		± 30	V
Drain current (DC) *	I_D	$T_c=25^\circ C$	10	A
		$T_c=100^\circ C$	6.32	A
Drain current (Pulsed) *	I_{DM}		40	A
Single avalanche energy ^(Note 2)	E_{AS}		480	mJ
Repetitive avalanche current ^(Note 1)	I_{AR}		10	A
Repetitive avalanche energy ^(Note 1)	E_{AR}		11.6	mJ
Power dissipation	P_D		40	W
Junction temperature	T_J		150	$^\circ C$
Storage temperature range	T_{stg}		-55-150	$^\circ C$

* Limited only maximum junction temperature

Thermal Characteristics

Characteristic	Symbol	Rating	Unit
Thermal resistance, junction to case	$R_{th(j-c)}$	Max. 3.1	$^{\circ}\text{C}/\text{W}$
Thermal resistance, junction to ambient	$R_{th(j-a)}$	Max. 62.5	

Electrical Characteristics ($T_c=25^{\circ}\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0$	600	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=10\text{V}, I_D=250\mu\text{A}$	2	-	4	V
Drain-source cut-off current	I_{DSS}	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
		$V_{DS}=600\text{V}, T_c=150^{\circ}\text{C}$	-	-	100	μA
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	-	-	± 100	nA
Drain-source on-resistance	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=5\text{A}$	-	0.6	0.75	Ω
Forward transfer conductance ^(Note 3)	g_{fs}	$V_{DS}=10\text{V}, I_D=5\text{A}$	-	8	-	S
Input capacitance	C_{iss}	$V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	-	2000	2350	pF
Output capacitance	C_{oss}		-	160	215	
Reverse transfer capacitance	C_{rss}		-	18	-	
Turn-on delay time ^(Note 3,4)	$t_{d(on)}$	$V_{DS}=300\text{V}, I_D=10\text{A}, R_G=25\Omega$	-	23	-	ns
Rise time ^(Note 3,4)	t_r		-	69	-	
Turn-off delay time ^(Note 3,4)	$t_{d(off)}$		-	144	-	
Fall time ^(Note 3,4)	t_f		-	77	-	
Total gate charge ^(Note 3,4)	Q_g	$V_{DS}=480\text{V}, V_{GS}=10\text{V}, I_D=10\text{A}$	28	35	42	nC
Gate-source charge ^(Note 3,4)	Q_{gs}		7.5	10	12.5	
Gate-drain charge ^(Note 3,4)	Q_{gd}		6.8	9	11.3	

Source-Drain Diode Ratings and Characteristics ($T_c=25^{\circ}\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	I_s	Integral reverse diode in the MOSFET	-	-	10	A
Source current (Pulsed)	I_{SM}		-	-	40	A
Forward voltage	V_{SD}	$V_{GS}=0\text{V}, I_{SD}=10\text{A}$	-	-	1.4	V
Reverse recovery time ^(Note 3,4)	t_{rr}	$I_{SD}=10\text{A}, V_{GS}=0\text{V}$ $dI_F/dt=100\text{A}/\mu\text{s}$	-	470	-	ns
Reverse recovery charge ^(Note 3,4)	Q_{rr}		-	6	-	μC

Note:

1. Repeated rating: Pulse width limited by safe operating area
2. $L=10\text{mH}, I_{AS}=4\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$, Starting $T_J=25^{\circ}\text{C}$
3. Pulse test: Pulse width $\leq 300\text{us}$, Duty cycle $\leq 2\%$
4. Essentially independent of operating temperature typical characteristics

Typical Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

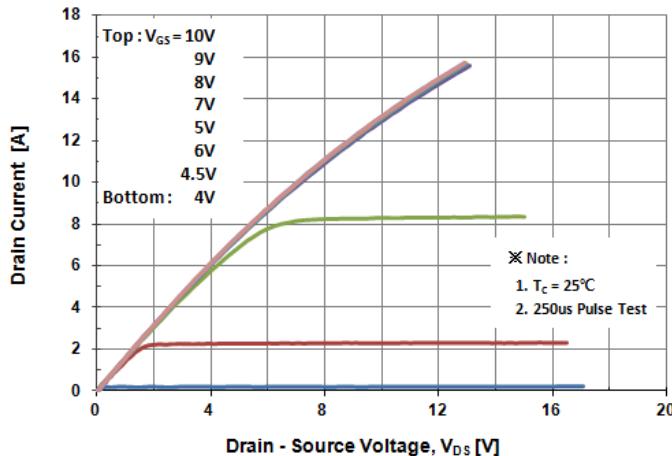


Fig.3 On-Resistance Variation with Drain Current and Gate Voltage

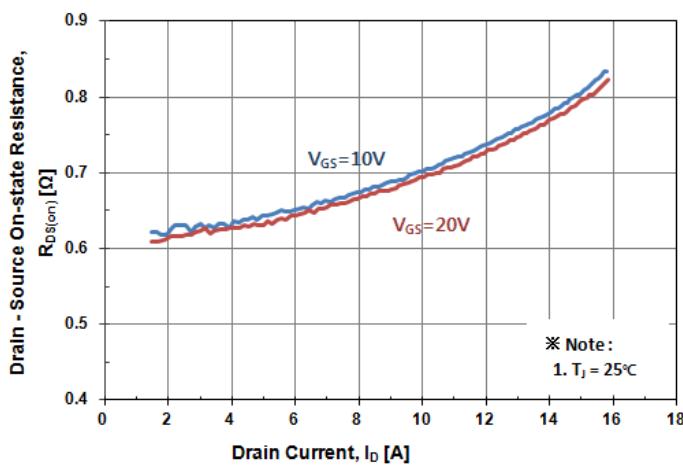


Fig. 5 Typical Capacitance Characteristics

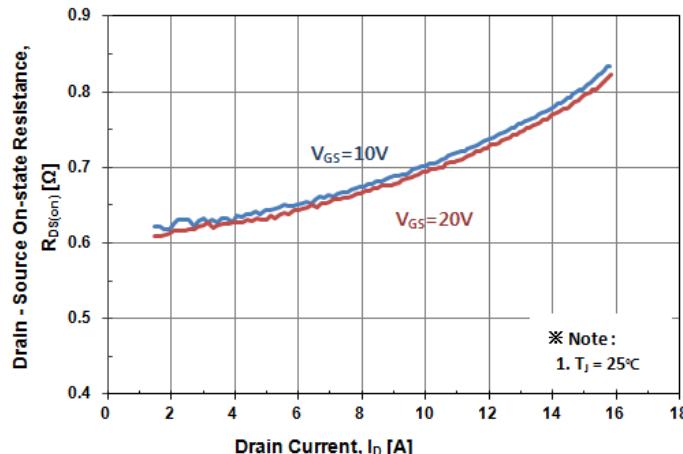


Fig. 2 Typical Output Characteristics

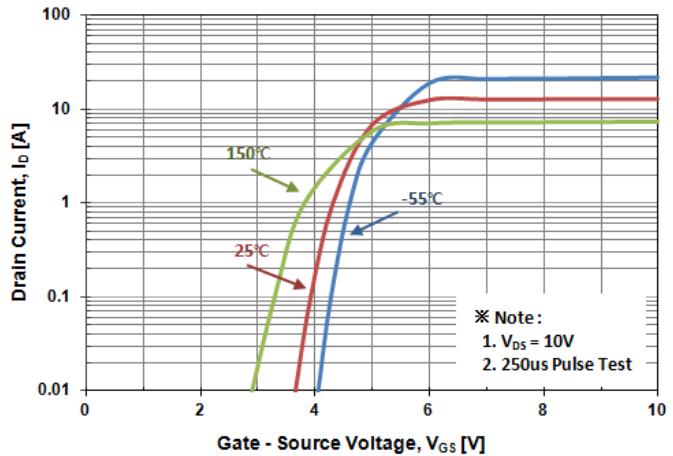


Fig. 4 Body Diode Forward Voltage Variation with Source Current

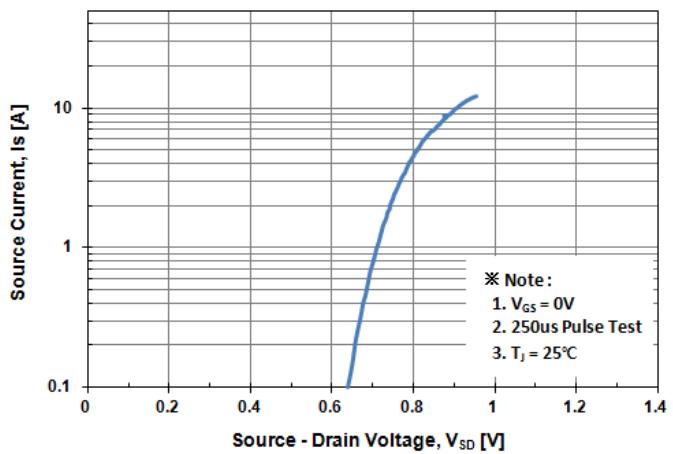


Fig. 6 Typical Total Gate Charge Characteristics

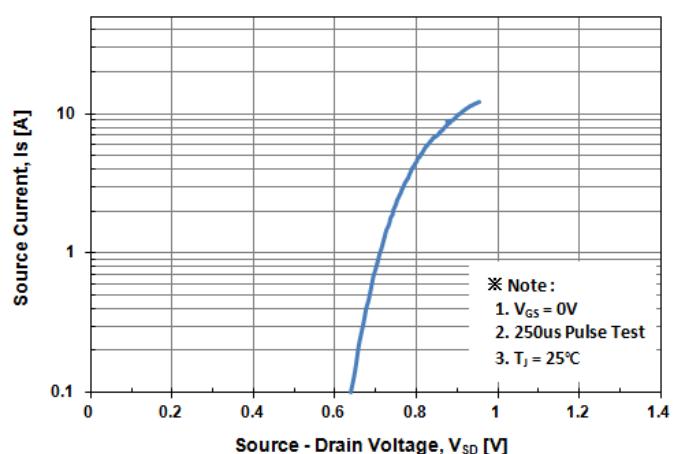


Fig. 7 Breakdown Voltage Variation vs. Temperature

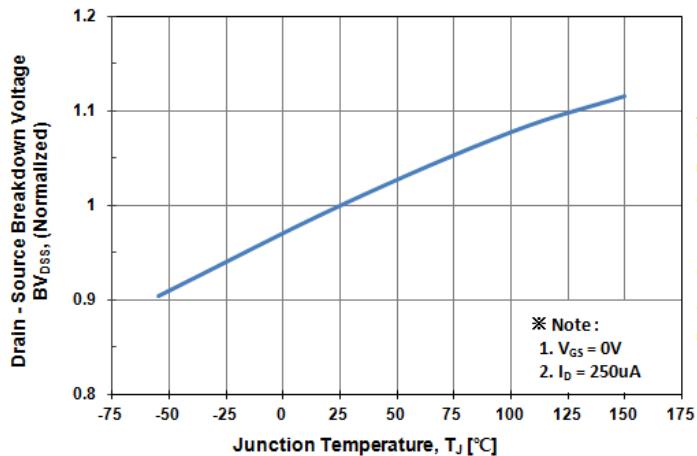


Fig. 9 Maximum Drain Current vs. Case Temperature

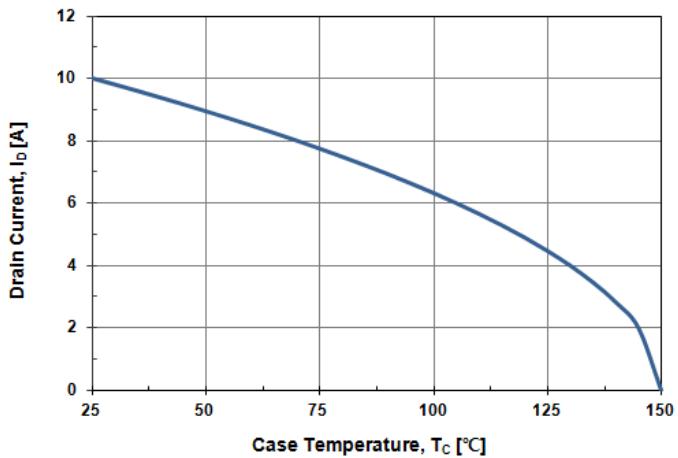


Fig. 11 Threshold Voltage Variation vs. Temperature

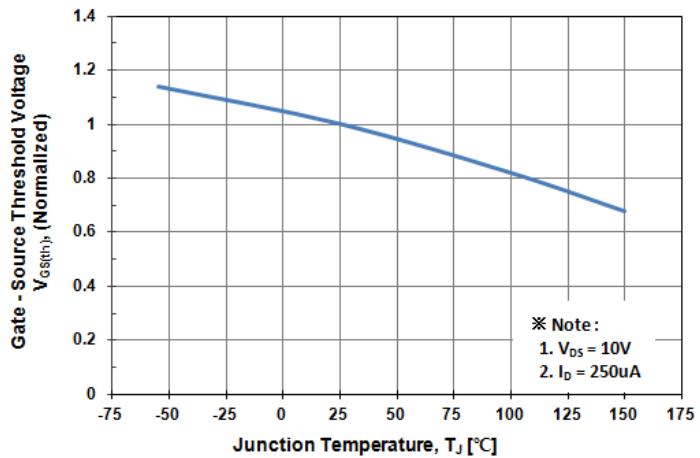


Fig. 8 On-Resistance Variation vs. Temperature

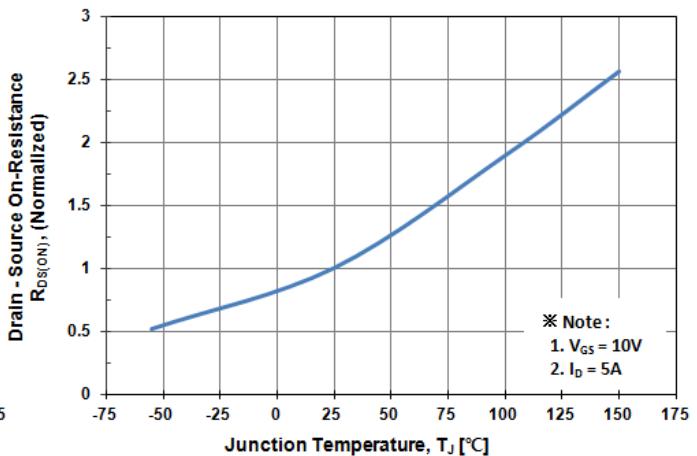


Fig. 10 Maximum Safe Operating Area

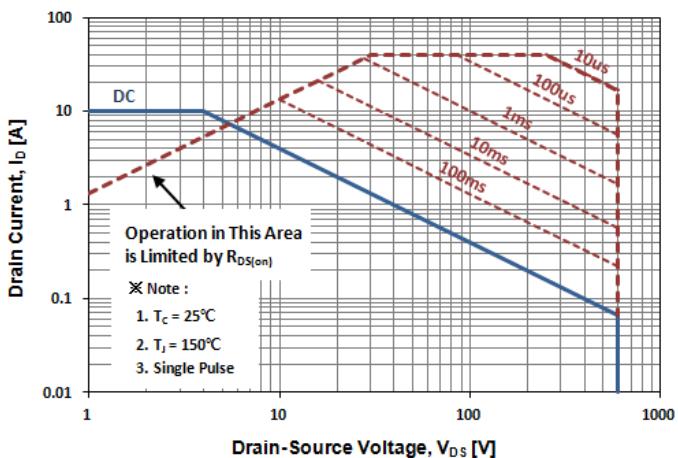


Fig. 12 Avalanche Energy vs. Temperature

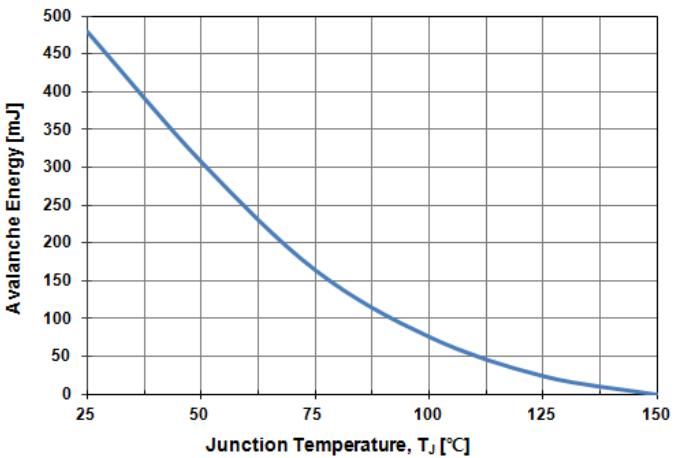


Fig. 13 Transient Thermal Impedance

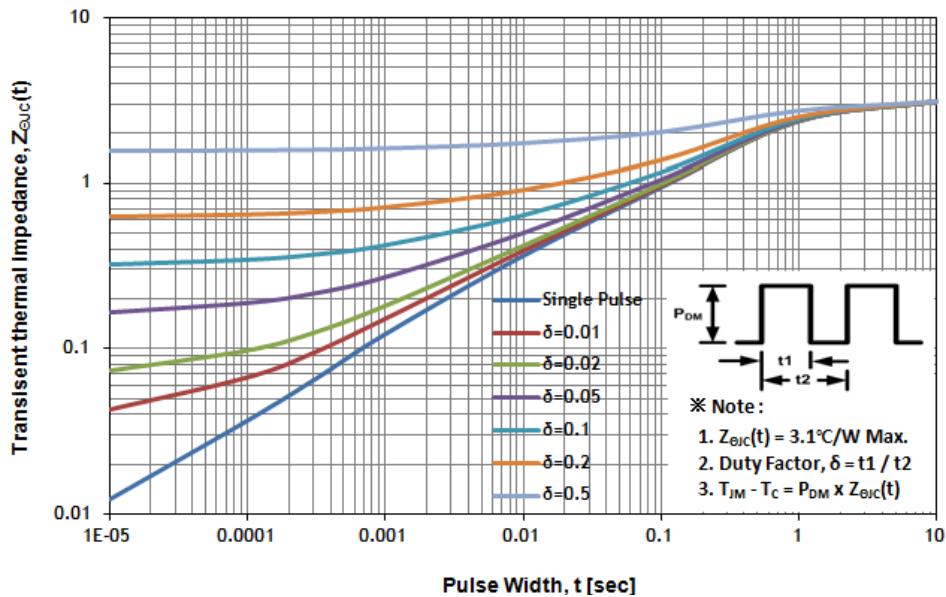


Fig. 14 Gate Charge Test Circuit & Waveform

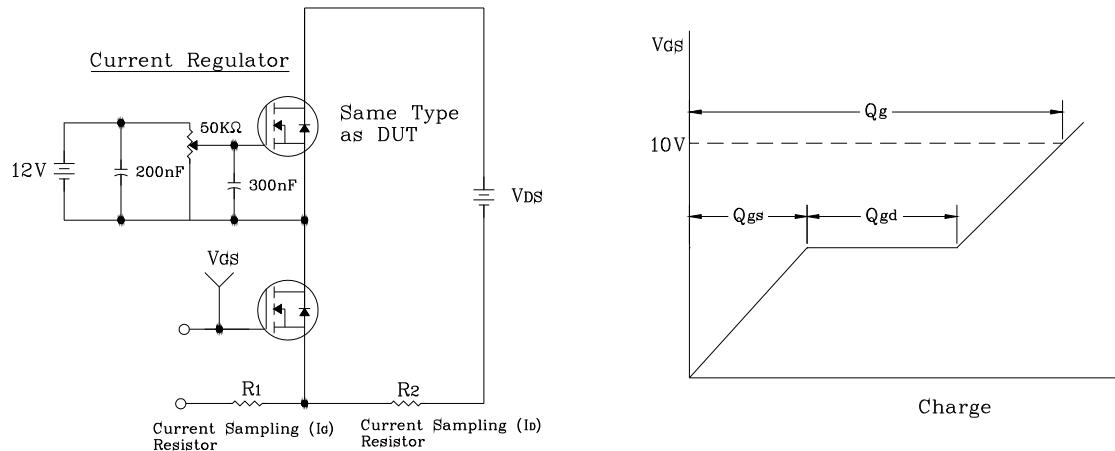


Fig. 15 Resistive Switching Test Circuit & Waveform

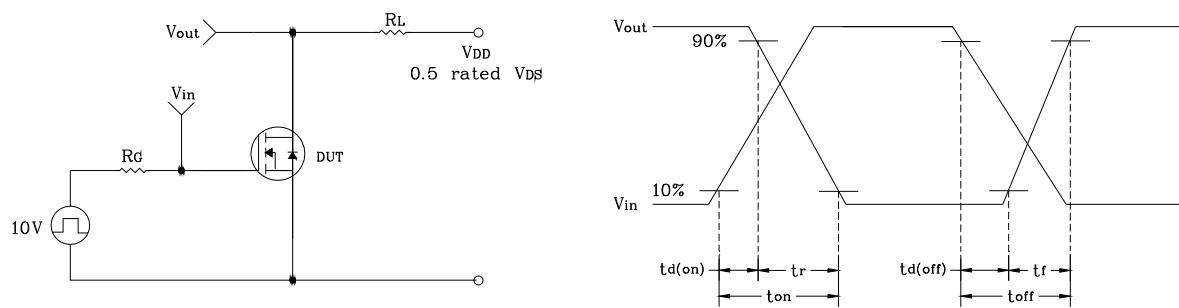


Fig. 16 E_{AS} Test Circuit & Waveform

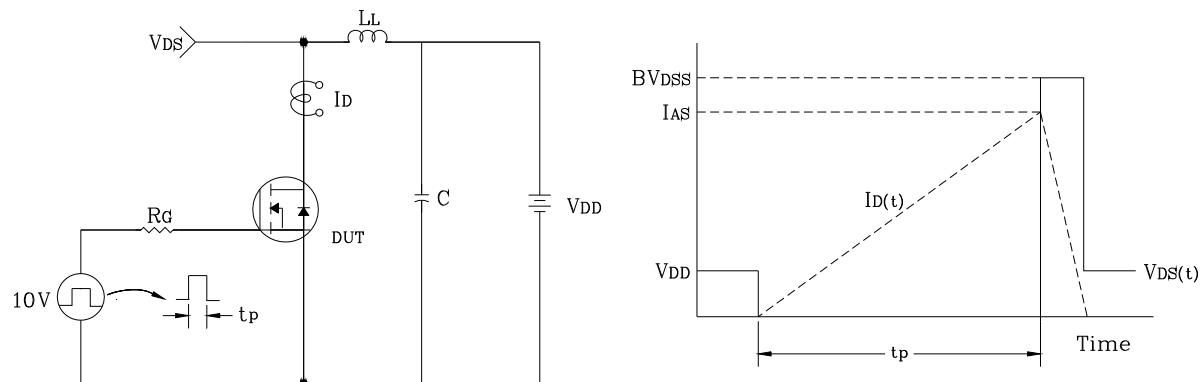
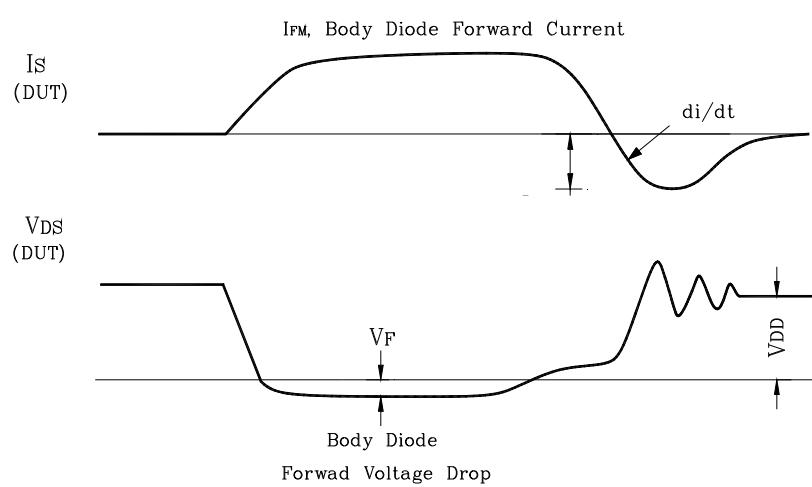
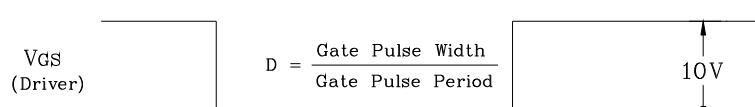
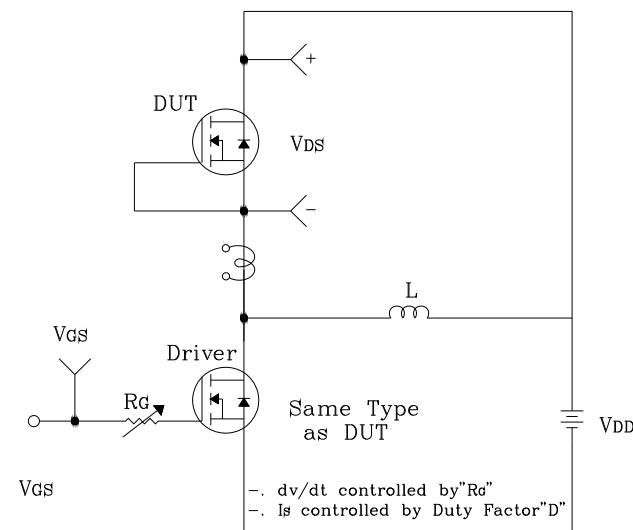
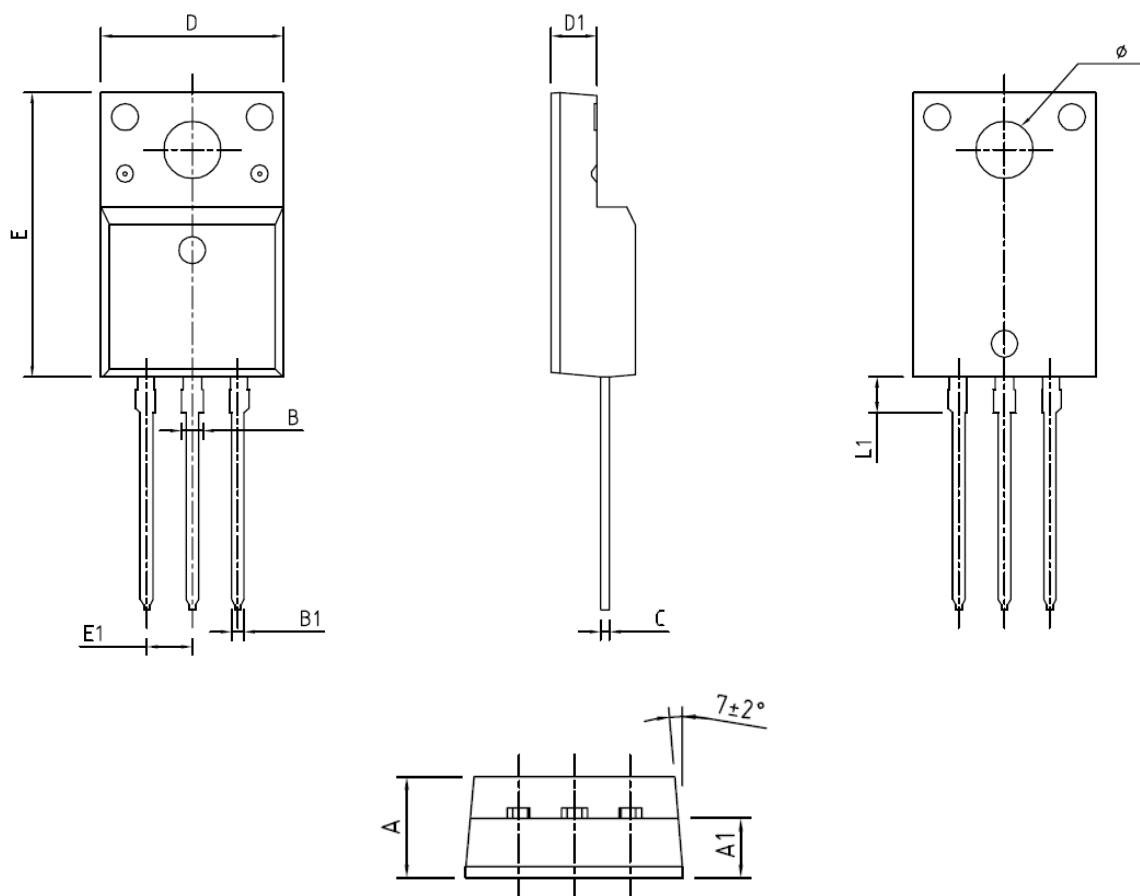


Fig. 17 Diode Reverse Recovery Time Test Circuit & Waveform



Package Outline Dimensions



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	4.50	4.70	4.90	
A1	2.61	2.76	2.91	
B	1.14	1.22	1.22	
B1	0.59	0.69	0.79	
C	0.45	0.50	0.60	
D	9.96	10.16	10.36	
D1	2.42	2.54	2.72	
E	15.67	15.87	16.07	
E1	2.44	2.54	2.64	
L	12.70	13.00	13.30	
L1	1.80	2.00	2.22	
Ø	3.08	3.18	3.28	

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